## **General Purpose Transistors** PNP Silicon

# 2N4403

**ON Semiconductor Preferred Device** 

#### MAXIMUM RATINGS

Rating	Symbol	Value	Unit
Collector-Emitter Voltage	VCEO	40	Vdc
Collector-Base Voltage	VCBO	40	Vdc
Emitter-Base Voltage	VEBO	5.0	Vdc
Collector Current — Continuous	IC	600	mAdc
Total Device Dissipation @ T <sub>A</sub> = 25°C Derate above 25°C	PD	625 5.0	mW mW/⁰C
Total Device Dissipation @ T <sub>C</sub> = 25°C Derate above 25°C	PD	1.5 12	Watt mW/ºC
Operating and Storage Junction Temperature Range	TJ, Tstg	-55 to +150	°C

#### THERMAL CHARACTERISTICS

Characteristic	Symbol	Max	Unit
Thermal Resistance, Junction to Ambient	$R_{\theta JA}$	200	°C/W
Thermal Resistance, Junction to Case	$R_{\theta JC}$	83.3	°C/W





1 EMITTER



#### ELECTRICAL CHARACTERISTICS (T<sub>A</sub> = 25°C unless otherwise noted)

Characteristic	Symbol	Min	Max	Unit	
OFF CHARACTERISTICS					
Collector–Emitter Breakdown Voltage <sup>(1)</sup> ( $I_C = 1.0 \text{ mAdc}, I_B = 0$ )	V(BR)CEO	40	-	Vdc	
Collector–Base Breakdown Voltage ( $I_C = 0.1 \text{ mAdc}, I_E = 0$ )	V(BR)CBO	40	-	Vdc	
Emitter–Base Breakdown Voltage ( $I_E = 0.1 \text{ mAdc}, I_C = 0$ )	V(BR)EBO	5.0	_	Vdc	
Base Cutoff Current (V <sub>CE</sub> = 35 Vdc, V <sub>EB</sub> = 0.4 Vdc)	IBEV	_	0.1	μAdc	
Collector Cutoff Current (V <sub>CE</sub> = 35 Vdc, V <sub>EB</sub> = 0.4 Vdc)	ICEX	—	0.1	μAdc	

1. Pulse Test: Pulse Width  $\leq 300~\mu s,$  Duty Cycle  $\leq 2.0\%.$ 

Preferred devices are ON Semiconductor recommended choices for future use and best overall value.

Characteristic	Symbol	Min	Max	Unit		
ON CHARACTERISTICS						
DC Current Gain (I <sub>C</sub> = 0.1 mAdc, V <sub>CE</sub> = 1.0 Vdc) (I <sub>C</sub> = 1.0 mAdc, V <sub>CE</sub> = 1.0 Vdc) (I <sub>C</sub> = 10 mAdc, V <sub>CE</sub> = 1.0 Vdc) (I <sub>C</sub> = 150 mAdc, V <sub>CE</sub> = 2.0 Vdc)(1) (I <sub>C</sub> = 500 mAdc, V <sub>CE</sub> = 2.0 Vdc)(1)	hfe	30 60 100 100 20	 	_		
Collector–Emitter Saturation Voltage <sup>(1)</sup> (I <sub>C</sub> = 150 mAdc, I <sub>B</sub> = 15 mAdc) (I <sub>C</sub> = 500 mAdc, I <sub>B</sub> = 50 mAdc)	VCE(sat)		0.4 0.75	Vdc		
Base–Emitter Saturation Voltage <sup>(1)</sup> ( $I_C = 150 \text{ mAdc}, I_B = 15 \text{ mAdc}$ ) ( $I_C = 500 \text{ mAdc}, I_B = 50 \text{ mAdc}$ )	VBE(sat)	0.75 —	0.95 1.3	Vdc		
SMALL-SIGNAL CHARACTERISTICS						
Current–Gain — Bandwidth Product (I <sub>C</sub> = 20 mAdc, V <sub>CE</sub> = 10 Vdc, f = 100 MHz)	fT	200	_	MHz		
Collector–Base Capacitance ( $V_{CB}$ = 10 Vdc, I <sub>E</sub> = 0, f = 1.0 MHz)	C <sub>cb</sub>		8.5	pF		
Emitter–Base Capacitance ( $V_{EB} = 0.5$ Vdc, $I_C = 0$ , f = 1.0 MHz)	C <sub>eb</sub>		30	pF		
Input Impedance (I <sub>C</sub> = 1.0 mAdc, V <sub>CE</sub> = 10 Vdc, f = 1.0 kHz)	h <sub>ie</sub>	1.5 k	15 k	ohms		
Voltage Feedback Ratio ( $I_C = 1.0 \text{ mAdc}$ , $V_{CE} = 10 \text{ Vdc}$ , $f = 1.0 \text{ kHz}$ )	h <sub>re</sub>	0.1	8.0	X 10 <sup>-4</sup>		
Small–Signal Current Gain (I <sub>C</sub> = 1.0 mAdc, V <sub>CE</sub> = 10 Vdc, f = 1.0 kHz)	h <sub>fe</sub>	60	500	_		
Output Admittance (I <sub>C</sub> = 1.0 mAdc, V <sub>CE</sub> = 10 Vdc, f = 1.0 kHz)	h <sub>OE</sub>	1.0	100	μmhos		
SWITCHING CHARACTERISTICS	ł					

Delay Time	(V <sub>CC</sub> = 30 Vdc, V <sub>BE</sub> = +2.0 Vdc,	td	—	15	ns
Rise Time	I <sub>C</sub> = 150 mAdc, I <sub>B1</sub> = 15 mAdc)	tr	-	20	ns
Storage Time	(V <sub>CC</sub> = 30 Vdc, I <sub>C</sub> = 150 mAdc,	t <sub>S</sub>	-	225	ns
Fall Time	I <sub>B1</sub> = 15 mA, I <sub>B2</sub> = 15 mA)	t <sub>f</sub>	_	30	ns

1. Pulse Test: Pulse Width  $\leq$  300 µs, Duty Cycle  $\leq$  2.0%.

### SWITCHING TIME EQUIVALENT TEST CIRCUIT

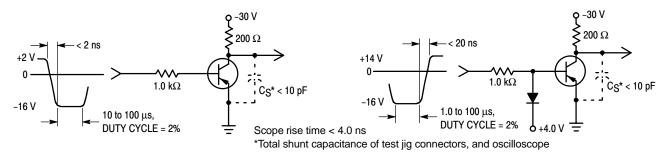
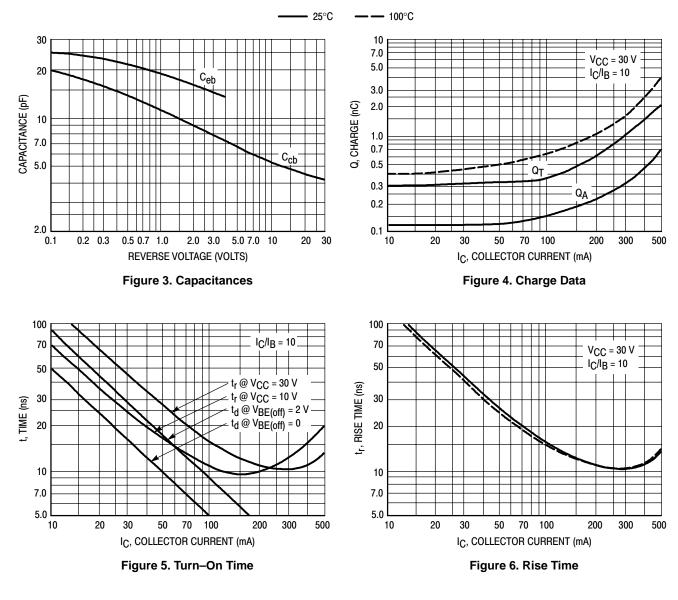


Figure 1. Turn–On Time

Figure 2. Turn–Off Time





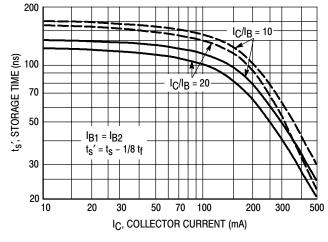
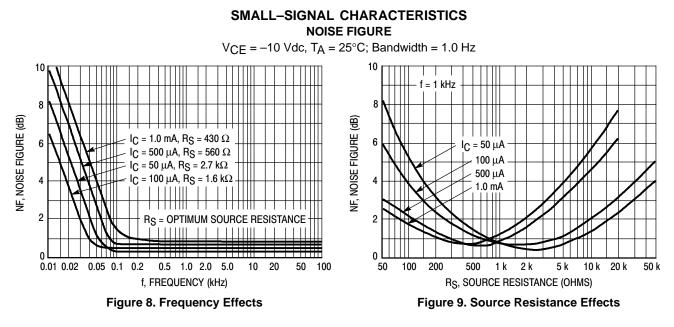


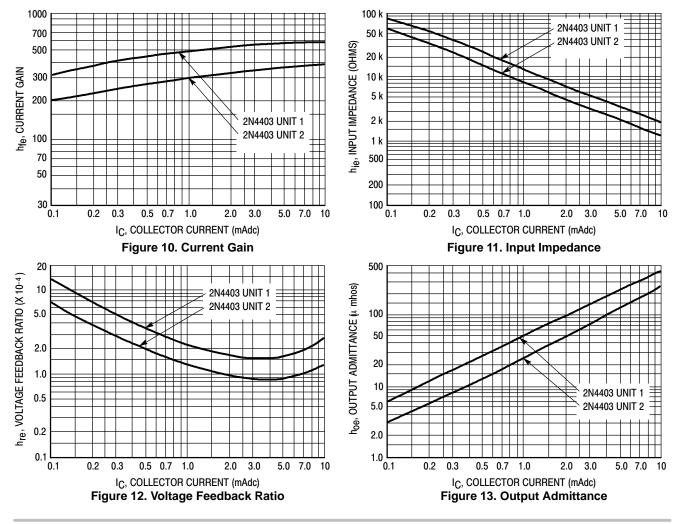
Figure 7. Storage Time



**h PARAMETERS** VCE = -10 Vdc, f = 1.0 kHz, T<sub>A</sub> = 25°C

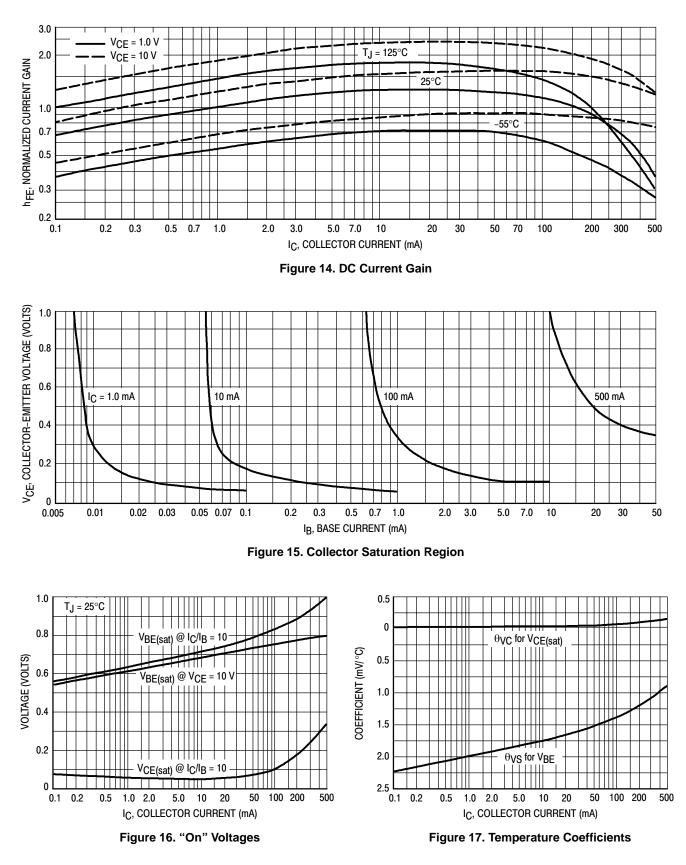
This group of graphs illustrates the relationship between  $h_{fe}$  and other "h" parameters for this series of transistors. To obtain these curves, a high–gain and a low–gain unit were

selected from the 2N4403 lines, and the same units were used to develop the correspondingly–numbered curves on each graph.



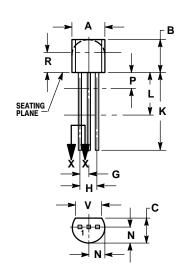
http://onsemi.com





### PACKAGE DIMENSIONS

TO-92 (TO-226) CASE 29-11 ISSUE AL







TYLE 1: PIN 1. EMITTER 2. BASE 3. COLLECTOR

NOTES: 1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982. 2. CONTROLLING DIMENSION: INCH. 3. CONTOUR OF PACKAGE BEYOND DIMENSION R IS UNCONTROLLED. 4. LEAD DIMENSION IS UNCONTROLLED IN P AND BEYOND DIMENSION K MINIMUM.

	INCHES		MILLIN	IETERS
DIM	MIN	MAX	MIN	MAX
Α	0.175	0.205	4.45	5.20
В	0.170	0.210	4.32	5.33
С	0.125	0.165	3.18	4.19
D	0.016	0.021	0.407	0.533
G	0.045	0.055	1.15	1.39
Н	0.095	0.105	2.42	2.66
J	0.015	0.020	0.39	0.50
K	0.500		12.70	
L	0.250		6.35	
Ν	0.080	0.105	2.04	2.66
Р		0.100		2.54
R	0.115		2.93	
٧	0.135		3.43	

# <u>Notes</u>

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